

<b>Notice of References Cited</b>	Application/Control No. 10/656,630	Applicant(s)/Patent Under Reexamination PARINS, DAVID J.	
	Examiner Jeffrey G. Hoekstra	Art Unit 3736	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2001/0009980 A1	07-2001	RICHARDSON et al.	600/585
*	B	US-6,849,224	02-2005	Wang et al.	264/478
*	C	US-2003/0069521	04-2003	Reynolds et al.	600/585
*	D	US-5,882,333	03-1999	Schaer et al.	604/95.01
*	E	US-6,152,912	11-2000	Jansen et al.	604/526
*	F	US-2002/0049392	04-2002	DeMello, Richard M.	600/585
*	G	US-5,222,949	06-1993	Kaldany, Antoine	604/524
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.